

N-Channel Enhancement Mode MOSFET

Feature

- 120V/60A
 R_{DS(ON)}=15mΩ (typ.) @ VGS = 10V
- 100% Avalanche Tested
- Reliable and Rugged
- Lead-Free and Green Devices Available (RoHS Compliant)

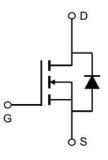
Pin Description



TO-220FB-3L

Applications

- Power Switching application
- High Frequency Synchronous Buck Converter



N-Channel MOSFET

Ordering and Marking Information



Package Code P:TO-220FB-3L

Date Code XYMXXXXXX

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plateTermi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Ra	tings (Tc=25°C Unless Otherwise Noted)		,	
VDSS	Drain-Source Voltage		120	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		-55 to 175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode) Tc=25°C		60	Α
Mounted on	Large Heat Sink			
І рм	Pulsed Drain Current *	Tc=25°C	210	А
	Out to the Darie Out of	Tc=25°C	60	Α
lσ	Continuous Drain Current	Tc=100°C	42	А
	M : B B: : ::	Tc=25°C	125	W
Po	Maximum Power Dissipation Tc=100°C		62.5	W
R _θ JC	Thermal Resistance, Junction-to-Case		1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		62	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	141.3	mJ

Note: * Repetitive rating; pulse width limited by max. junction temperature.

** Surface mounted on FR-4 board.

*** Limited by TJmax, starting TJ=25°C, L = 0.3mH, VDS=96V, VGS =10V.

Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

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Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics					
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	120	-	-	V
	I _{DSS} Drain-to-Source Leakage Current	V _{DS} =120V,V _{GS} =0V	-	-	1.0	μA
IDSS		TJ=125°C	-	-	50	μA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	2	3	4	V
Igss	Gate-Source Leakage Current	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =30A	-	15	20	mΩ
Diode Cha	racteristics			•		
VsD*	Diode Forward Voltage	Isp=30A,Vgs=0V	-	0.88	1.3	V
trr	Reverse Recovery Time	lon=20	-	44	-	ns
Qrr	Reverse Recovery Charge	Isp=30A,dIsp/dt=100A/µs	-	81.1	_	nC

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Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Comple al	Dava-mata-r	Toot Conditions	HY	HYG200N12NS1		
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic (Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	2.5	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	2350	-	
Coss	Output Capacitance	V _{DS} =25V,	-	327	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	18	-	
td(ON)	Turn-on Delay Time		-	13.3	-	
Tr	Turn-on Rise Time	V_{DD} =60 V , R_{G} =2.5 Ω ,	-	41.1	-	
t d(OFF)	Turn-off Delay Time	lps=30A,Vgs=10V	-	22.9	-	ns
Tf	Turn-off Fall Time		-	26.8	-	
Gate Chai	Gate Charge Characteristics					
Qg	Total Gate Charge	\/ -06\/ \/ -10\/	-	33.1	-	
Qgs	Gate-Source Charge	V_{DS} =96V, V_{GS} =10V, V_{DS} =30A	-	13.5	-	nC
Q_{gd}	Gate-Drain Charge	ID-304	-	5.3	-	

Note: *Pulse test, pulse width ≤ 300us, duty cycle ≤ 2%



Typical Operating Characteristics

Figure 1: Power Dissipation

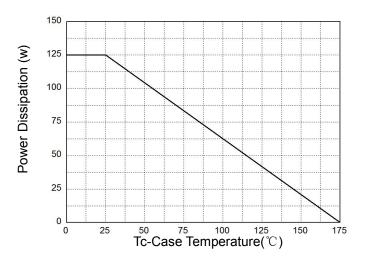


Figure 2: Drain Current

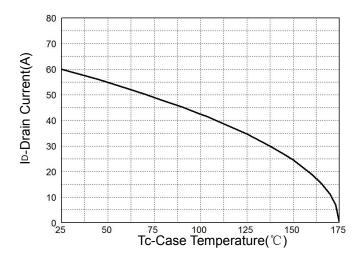


Figure 3: Safe Operation Area

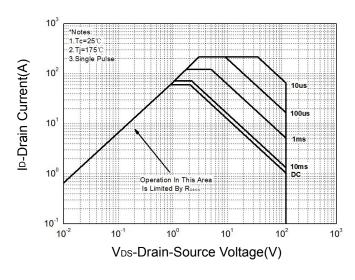


Figure 4: Thermal Transient Impedance

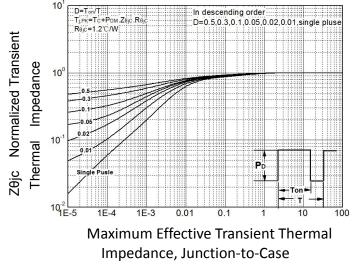


Figure 5: Output Characteristics

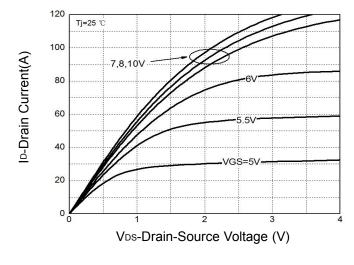
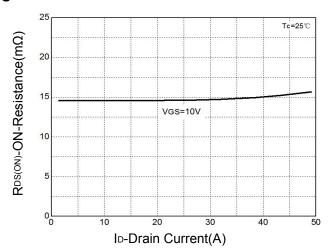


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

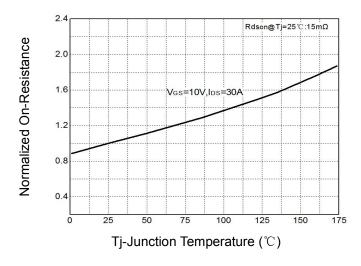


Figure 8: Source-Drain Diode Forward

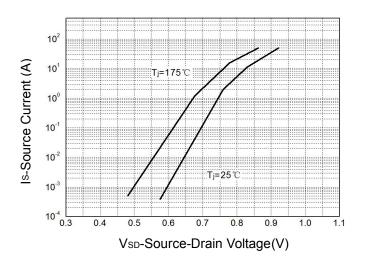


Figure 9: Capacitance Characteristics

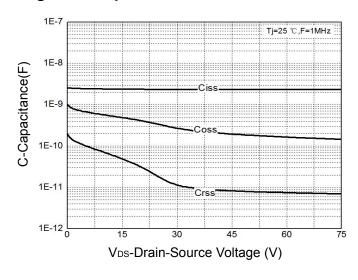
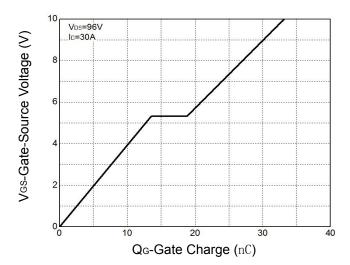
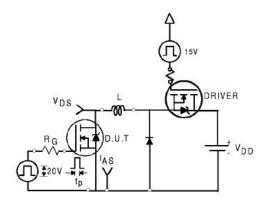


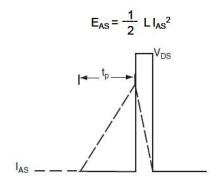
Figure 10: Gate Charge Characteristics



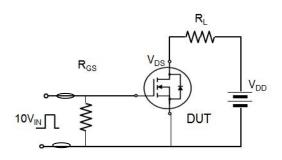


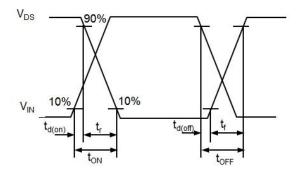
Avalanche Test Circuit



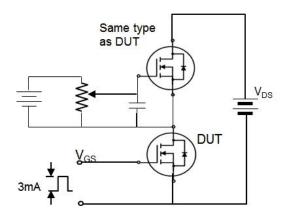


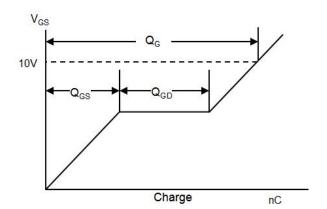
Switching Time Test Circuit





Gate Charge Test Circuit





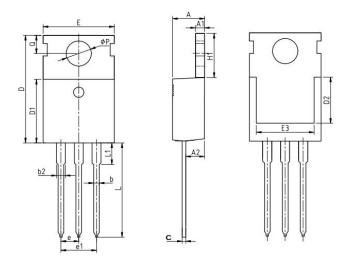


Device Per Unit

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50

Package Information

TO-220FB-3L

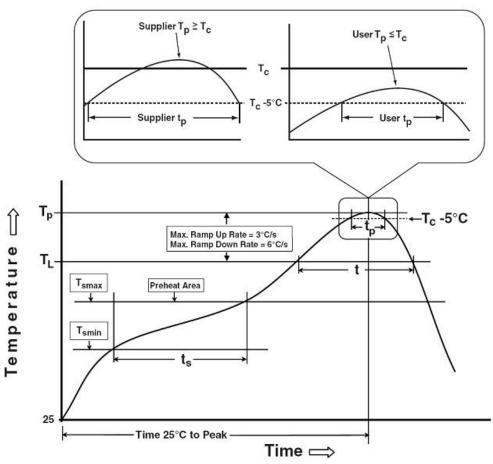


COMMON DIMENSIONS

SYMBOL	mm			
STIVIBUL	MIN	NOM	MAX	
А	4.37	4.57	4.77	
A1	1.25	1.30	1.45	
A2	2.20	2.40	2.60	
b	0.70	0.80	0.95	
b2	1.17	1.27	1.47	
С	0.40	0.50	0.65	
D	15.10	15.60	16.10	
D1	8.80	9.10	9.40	
D2	5.50	-	-	
E	9.70	10.00	10.30	
E3	7.00	-	-	
е		2.54 BSC		
e1	5.08 BSC			
H1	6.25	6.50	6.85	
L	12.75	13.50	13.80	
L1	-	3.10	3.40	
ФР	3.40	3.60	3.80	
Q	2.60	2.80	3.00	



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly	
Preheat & Soak	100 °C	150 °C	
Temperature min (T _{smin})	150 °C	200 °C	
Temperature max (T _{smax})	60-120 seconds	60-120 seconds	
Time (Tsmin to Tsmax) (ts)	00-120 Seconds	60-120 seconds	
Average ramp-up rate	3 °C/second max.	3°C/second max.	
(T _{smax} to T _P)	5 C/second max.		
Liquidous temperature (TL)	183 °C	217 °C	
Time at liquidous (t∟)	60-150 seconds	60-150 seconds	
Peak package body Temperature	See Classification Temp in table 1	SeeClassification Tempin table 2	
(T _p)*	See Classification Temp in table 1		
Time (t _P)** within 5°C of the specified	20** seconds	30** seconds	
classification temperature (T _c)	20 seconds	30 seconds	
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.	
Time 25°C to peak temperature	6 minutes max.	8 minutes max.	
*Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.			

^{**} Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 Hrs/500hr/1000hr, V _{gs} 100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

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